

# LINEAR SYSTEMS

## Linear Integrated Systems

### LS-U401 - U406

LOW NOISE LOW DRIFT  
MONOLITHIC DUAL N-CHANNEL JFET

#### FEATURES

LOW DRIFT	$ V_{GS1-2}/T  = 10\mu V/\text{°C}$ TYP.
LOW NOISE	$e_n = 6nV/\text{Hz}$ @10Hz TYP.
LOW PINCHOFF	$V_p = 2.5V$ TYP.

#### ABSOLUTE MAXIMUM RATINGS NOTE 1

@ 25°C (unless otherwise noted)

#### Maximum Temperatures

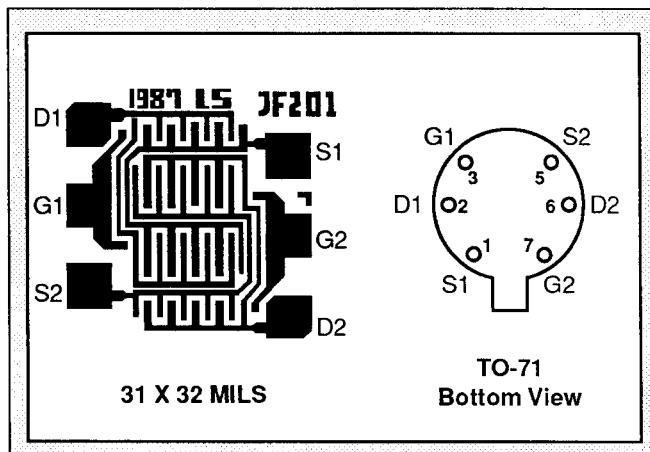
Storage Temperature	-65° to +150°C
Operating Junction Temperature	+150°C

#### Maximum Voltage and Current for Each Transistor NOTE 1

$-V_{GSS}$	Gate Voltage to Drain or Source	50V
$-V_{DS0}$	Drain to Source Voltage	50V
$-I_{G(f)}$	Gate Forward Current	10mA

#### Maximum Power Dissipation

Device Dissipation @ Free Air - Total 300mW



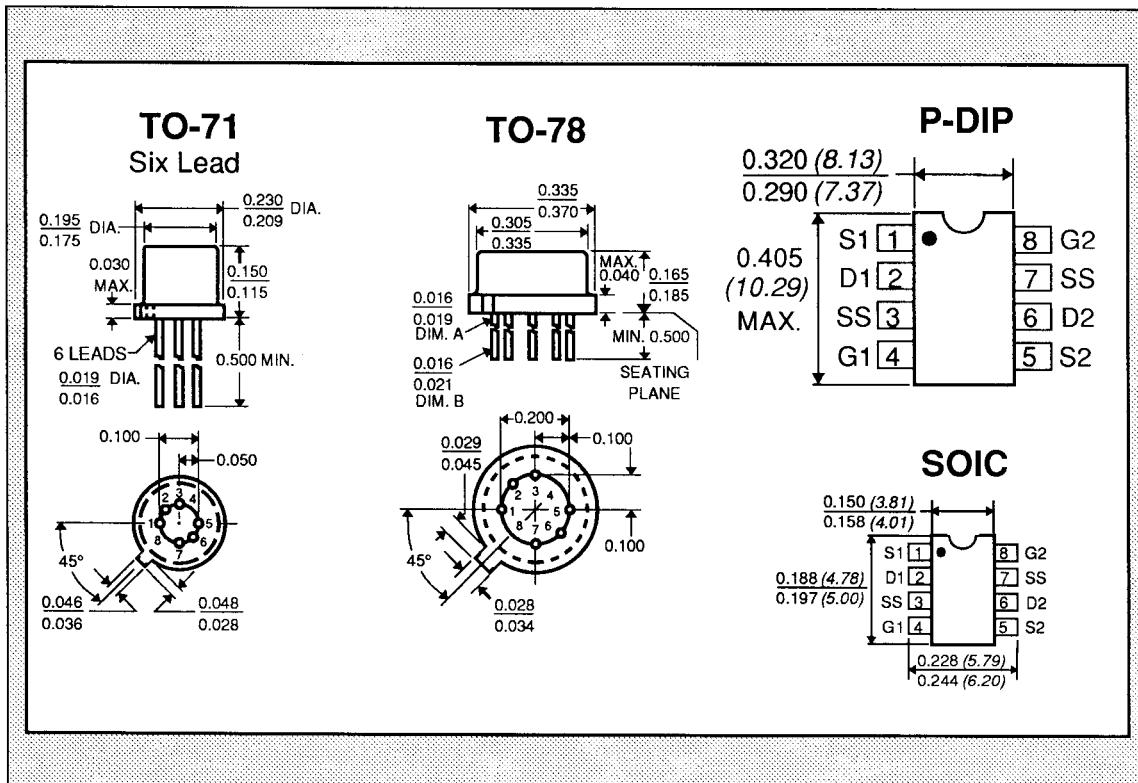
#### MATCHING CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTICS	LS-401	LS-402	LS-403	LS-404	LS-405	LS-406	UNITS	CONDITIONS
$ V_{GS1-2}/T $ max.	Drift vs. Temperature	10	10	25	25	40	80	$\mu V/\text{°C}$	$V_{DG} = 10V, I_D = 200\mu A$ $T_A = -55\text{°C}$ to +125°C
$ V_{GS1-2} $ max.	Offset Voltage	5	10	10	15	20	40	mV	$V_{DG} = 10V, I_D = 200\mu A$

#### ELECTRICAL CHARACTERISTICS

SYMBOL	CHARACTERISTICS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
$BV_{GSS}$	Breakdown Voltage	50	60	--	V	$V_{DS} = 0$ $I_D = 1nA$
$BV_{GGO}$	Gate-to-Gate Breakdown	$\pm 50$	--	--	V	$I_G = 1nA$ $I_D = 0$ $I_S = 0$
<b>TRANSCONDUCTANCE</b>						
$Y_{fs}$	Full Conduction	2000	--	7000	$\mu mho$	$V_{DG} = 10V$ $V_{GS} = 0$ $f = 1kHz$
$Y_{fs}$	Typical Operation	1000	--	2000	$\mu mho$	$V_{DG} = 15V$ $I_D = 200\mu A$ $f = 1kHz$
$ Y_{fs1-2}/Y_{fs} $	Mismatch	--	0.6	3	%	
<b>DRAIN CURRENT</b>						
$I_{DSS}$	Full Conduction	0.5	--	10	mA	$V_{DG} = 10V$ $V_{GS} = 0$
$ I_{DSS1-2}/I_{DSS} $	Mismatch at Full Conduction	--	1	5	%	
<b>GATE VOLTAGE</b>						
$V_{GS}$ (off) or $V_p$	Pinchoff Voltage	-0.5	--	-2.5	V	$V_{DS} = 15V$ $I_D = 1nA$
$V_{GS}$ (on)	Operating Range	--	--	-2.3	V	$V_{DS} = 15V$ $I_D = 200\mu A$
<b>GATE CURRENT</b>						
$-I_G$ max.	Operating	--	-4	-15	pA	$V_{DG} = 15V$ $I_D = 200\mu A$
$-I_G$ max.	High Temperature	--	--	-10	nA	$T_A = +125\text{°C}$
$-I_{GSS}$ max.	At Full Conduction	--	--	100	pA	$V_{DS} = 0V$
$-I_{GSS}$ max.	High Temperature	5	5	5	pA	$V_{DG} = 15V$ $T_A = +125\text{°C}$

SYMBOL	CHARACTERISTICS	MIN.	TYP.	MAX.	UNITS	CONDITIONS
$Y_{oss}$	<u>OUTPUT CONDUCTANCE</u> Full Conduction	--	--	20	$\mu\text{mho}$	$V_{DG} = 10V$ $V_{GS} = 0$
$Y_{os}$	Operating	--	0.2	2	$\mu\text{mho}$	$V_{DG} = 15V$ $I_D = 500\mu\text{A}$
CMR	<u>COMMON MODE REJECTION</u> $-20 \log  V_{GS1-2}/V_{DS} $	95	--	--	dB	$V_{DS} = 10$ to $20V$ $I_D = 30\mu\text{A}$
NF	<u>NOISE</u> Figure	--	--	0.5	dB	$V_{DS} = 15V$ $V_{GS} = 0$ $R_G = 10M$ $f = 100\text{Hz}$ $\text{NBW} = 6\text{Hz}$
$e_n$	Voltage	--	20	--	nV/ Hz	$V_{DS} = 15V$ $I_D = 200\mu\text{A}$ $f = 10\text{Hz}$ $\text{NBW} = 1\text{Hz}$
$C_{ISS}$	<u>CAPACITANCE</u> Input	--	--	8	pF	$V_{DS} = 15V$ $I_D = 200\mu\text{A}$ $f = 1\text{MHz}$
$C_{RSS}$	Reverse Transfer	--	--	1.5	pF	



#### NOTES:

- These ratings are limiting values above which the serviceability of any semiconductor may be impaired.